

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/771,442 | Applicant(s)/Patent Under Reexamination LO, JUI-YANG | |
| | Examiner John E Chapman | Art Unit 2856 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-4,631,515 | 12-1986 | Blee et al. | 340/441 |
| | B | US-5,975,728 | 11-1999 | Weyer, Frank M. | 362/489 |
| | C | US-6,137,399 | 10-2000 | Westberg et al. | 340/441 |
| | D | US-6,302,551 | 10-2001 | Matumoto, Makoto | 362/489 |
| | E | US-6,441,726 | 08-2002 | Voto et al. | 340/438 |
| | F | US-6,717,376 | 04-2004 | Lys et al. | 362/489 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.